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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

re Patent Application of

**RÖKMAN et al**Atty. Ref.: **3952-78**Serial No. **10/530,408**Art Unit: **1724**National Phase of: **PCT/FI2003/000748**International Filing Date: **9 October 2003**Filed: **June 1, 2005**

Examiner:

For: **IMPROVED FILTERING MEDIUM AND USE OF THE SAID  
FILTERING MEDIUM FOR POLLUTION REMOVAL FROM  
LAGOONS**

\* \* \* \* \*

July 13, 2005

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Sir:

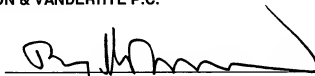
As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the references listed on the attached form PTO-1449. Copies of all non-U.S. references are enclosed. This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited. A copy of the International Search Report is enclosed.

The Examiner is requested to initial the attached form PTO-1449 and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

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By:

  
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### INFORMATION DISCLOSURE CITATION

~~ATTY. DOCKET NO.~~

SERIAL NO.

**3952-78**

10/530,408

**APPELLANT**

RÖKMAN et al

**FINIS DATE**

**GROUP**

**June 1, 2005**

~~1724~~ 1797

## U.S. PATENT DOCUMENTS

[illegible]

**FOREIGN PATENT DOCUMENTS**

							TRANSLATION	
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO	
/RH/	WO 99/08784	2/1999	WIPO	<u>          </u>	<u>          </u>			
/RH/	2 812 825	2/2002	FR	<u>          </u>	<u>          </u>		X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

/RH/	DATABASE WPI XP-002277671 & JP 58 138326, 17 August 1983
/RH/	DATABASE WPI XP-002251685 & JP 53 061582, 2 June 1978
/RH/	DATABASE WPI XP-002251686 & JP 53 061581, 2 June 1978
/RH/	DATABASE WPI XP-002251687 & JP 50 011352, 30 April 1975
/RH/	PATENT ABSTRACTS OF JAPAN, vol. 2000, no. 12, 3 January 2001 & JP 2000 263678 A, 26 September 2000
/RH/	PATENT ABSTRACTS OF JAPAN, vol. 1999, no. 12, 29 October 1999 & JP 11 192428 A, 21 July 1999
/RH/	International Search Report 6/17/04
*Examiner	/Robert Hopkins/
	Date Considered 03/18/2008

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.